

MOS FIELD EFFECT TRANSISTOR NP34N055HHE, NP34N055IHE

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

These products are N-Channel MOS Field Effect Transistors designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance
 R_{DS(on)} = 19 mΩ MAX. (V_{GS} = 10 V, I_D = 17 A)
- Low Ciss : Ciss = 1600 pF TYP.
- · Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE		
NP34N055HHE	TO-251		
NP34N055IHE	TO-252		

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage	VDSS	55	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC)	I _{D(DC)}	±34	Α
Drain Current (Pulse) Note1	D(pulse)	±136	Α
Total Power Dissipation (T _A = 25 °C)	Рт	1.2	W
Total Power Dissipation (Tc = 25 °C)	Рт	88	W
Single Avalanche Current Note2	las	34 / 27 / 10	Α
Single Avalanche Energy Note2	Eas	11 / 72 / 100	mJ
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to + 175	°C

(TO-251)



(10-252)



Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting T_{ch} = 25 °C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V (see Figure 4.)

THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	1.70	°C/W
Channel to Ambient	Rth(ch-A)	125	°C/W

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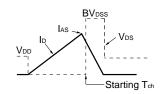


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

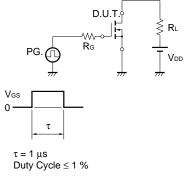
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Ib = 17 A		15	19	mΩ
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 17 A	6	12		S
Drain Leakage Current	IDSS	V _{DS} = 55 V, V _{GS} = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	Vps = 25 V		1600	2400	pF
Output Capacitance	Coss	Vgs = 0 V		250	380	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		120	220	pF
Turn-on Delay Time	td(on)	I _D = 17 A		21	47	ns
Rise Time	tr	V _{GS(on)} = 10 V		15	38	ns
Turn-off Delay Time	td(off)	VDD = 28 V		35	70	ns
Fall Time	tr	$R_G = 1 \Omega$		12	29	ns
Total Gate Charge	QG	ID = 34 A		30	45	nC
Gate to Source Charge	Qgs	V _{DD} = 44 V		9		nC
Gate to Drain Charge	Q _{GD}	V _G S = 10 V		12		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 34 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 34 A, VGS = 0 V		40		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		58		nC

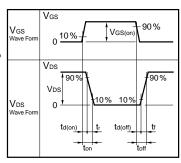
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \Omega \\ \text{Vgs} = 20 \rightarrow 0 \text{V} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{S} 50 \Omega \\ \text{W} \end{array}$



TEST CIRCUIT 2 SWITCHING TIME

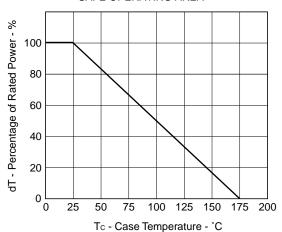


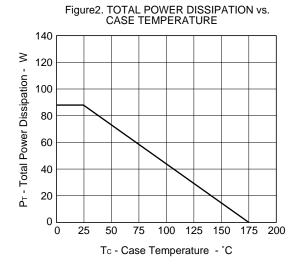


TEST CIRCUIT 3 GATE CHARGE

TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA





★ Figure3. FORWARD BIAS SAFE OPERATING AREA

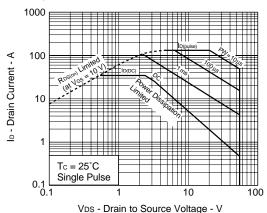


Figure4. SINGLE AVALANCHE ENERGY DERATING FACTOR

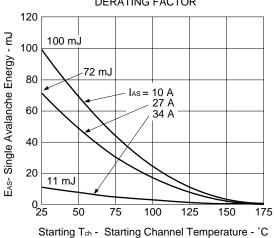


Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

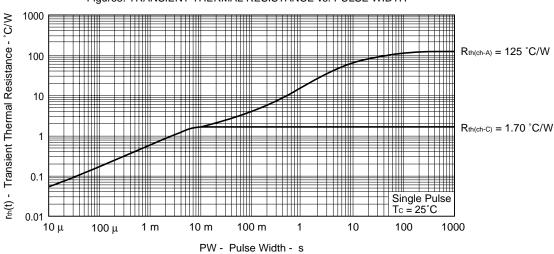


Figure 6. FORWARD TRANSFER CHARACTERISTICS

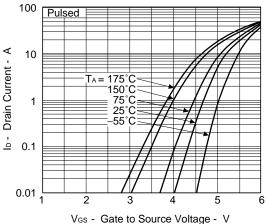
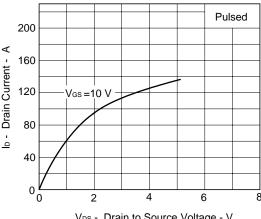


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



V_{DS} - Drain to Source Voltage - V

Figure 8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

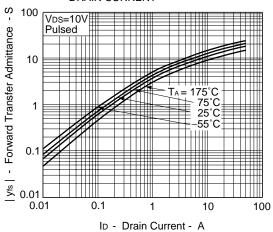
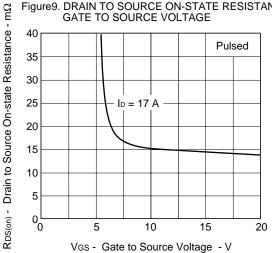


Figure 9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



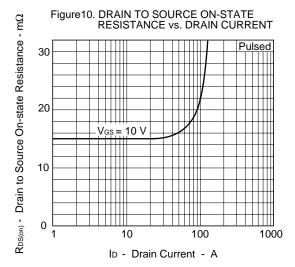
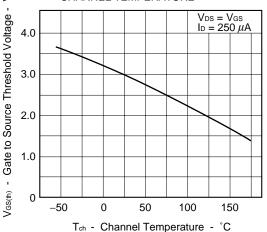


Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE





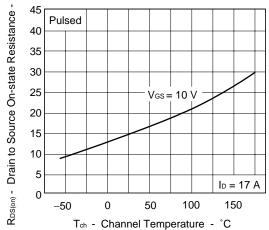


Figure14. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

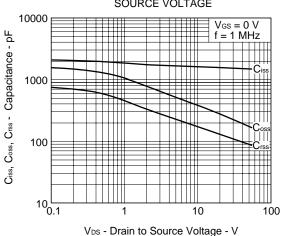


Figure 16. REVERSE RECOVERY TIME vs. DRAIN CURRENT

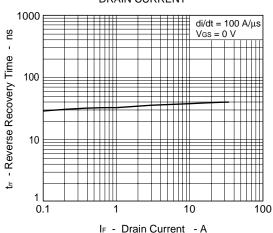


Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

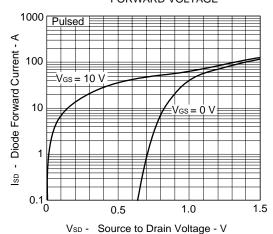


Figure 15. SWITCHING CHARACTERISTICS

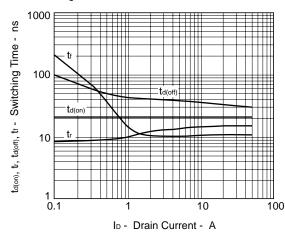
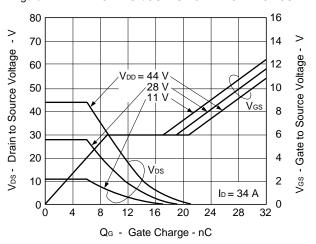
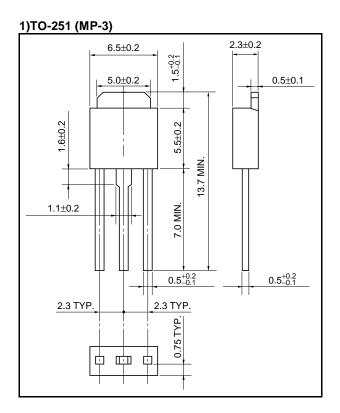


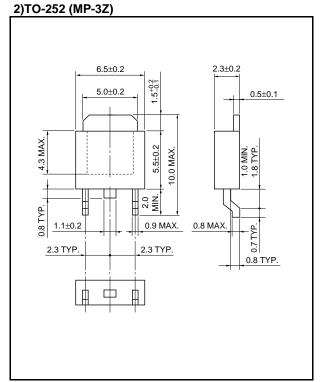
Figure 17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS



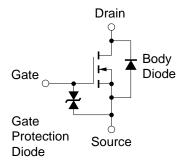


PACKAGE DRAWINGS (Unit: mm)





EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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